


<b>Search Notes</b>  	<b>Application/Control No.</b>  10617386	<b>Applicant(s)/Patent Under Reexamination</b>  NAKANO ET AL.
	<b>Examiner</b>  Sheng, Tom V	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	55, 56, 87, 98, 100, 205	9/5/05, 4/19/06, 12/13/06, 7/13/07	TS

SEARCH NOTES		
Search Notes	Date	Examiner
Inventor Search	9/6/05, 7/13/07	TS
EAST Search	9/5/05, 4/19/06, 12/13/06, 12/21/06, 7/13/07	TS

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
345	98, 205	7/13/2007	TS